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DISPLAY APPARATUS INCLUDING A BLOCKING LAYER AND METHOD OF MANUFACTURING THE SAME

Abstract

A display apparatus includes: a substrate including a display area and a sensor area, wherein the display area includes a first pixel, and the sensor area includes a second pixel and a transmission portion; a sensor configured to transmit a signal through the substrate via the transmission portion, wherein the second pixel includes second thin-film transistor including a semiconductor layer, and wherein a blocking layer is disposed between the sensor and the second thin-film transistor, wherein the blocking layer covers the semiconductor layer.

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Background/Summary

CROSS-REFERENCE TO RELATED APPLICATIONS [0001] This application is a continuation of co-pending U.S. patent application Ser. No. 18/219,828, filed on Jul. 10, 2023, which is a continuation of U.S. patent application Ser. No. 17/592,658 filed on Feb. 4, 2022, now U.S. Pat. No. 11,737,319, issued on Aug. 22, 2023, which is a continuation of U.S. patent application Ser. No. 16/551,076 filed on Aug. 26, 2019, now U.S. Pat. No. 11,271,055, issued on Mar. 8, 2022, which claims priority under 35 U.S.C. § 119 to Korean Patent Application No. 10-2019-0005858, filed on Jan. 16, 2019, in the Korean Intellectual Property Office, the disclosures of which are incorporated by reference herein in their entireties.

TECHNICAL FIELD

[0002] Exemplary embodiments of the present inventive concept relate to a display apparatus and a method of manufacturing the same, and more particularly, to display apparatus including a blocking layer and a method of manufacturing the same.

DISCUSSION OF THE RELATED ART

[0003] Generally, display apparatuses have various purposes. In addition, as display apparatuses have become thinner and lighter, the display apparatuses have become increasingly widely used.

[0004] As the display apparatuses are variously utilized, various methods may be used to design forms of the display apparatuses. In addition, functions that may be combined or linked with the display apparatuses are also increasing.

SUMMARY

[0005] According to an exemplary embodiment of the present inventive concept, a display apparatus includes: a substrate including a display area and a sensor area, wherein the display area includes a first pixel, and the sensor area includes a second pixel and a transmission portion; a sensor configured to transmit a signal through the substrate via the transmission portion, wherein the second pixel includes second thin-film transistor including a semiconductor layer, and wherein a blocking layer is disposed between the sensor and the second thin-film transistor, wherein the blocking layer covers the semiconductor layer.

[0006] In an exemplary embodiment of the present inventive concept, the blocking layer has a same pattern as a pattern of the semiconductor layer in the second thin-film transistor.

[0007] In an exemplary embodiment of the present inventive concept, a width of the pattern of the blocking layer is greater than a width of the pattern of the semiconductor layer in the second thin-film transistor.

[0008] In an exemplary embodiment of the present inventive concept, the blocking layer has a different pattern from a pattern of the semiconductor layer in the second thin-film transistor.

[0009] In an exemplary embodiment of the present inventive concept, a thickness of the blocking layer is about 800 Å or greater.

[0010] In an exemplary embodiment of the present inventive concept, buffer layers are arranged between the second thin-film transistor and the blocking layer and between the blocking layer and the substrate, respectively.

[0011] In an exemplary embodiment of the present inventive concept, the second pixel further includes an organic light-emitting diode connected to the second thin-film transistor.

[0012] In an exemplary embodiment of the present inventive concept, the first pixel includes a first thin-film transistor including a semiconductor layer, and wherein a blocking layer is arranged between the sensor and the first thin-film transistor to cover the semiconductor layer in the first thin-film transistor.

[0013] In an exemplary embodiment of the present inventive concept, the first pixel further includes an organic light-emitting diode connected to the first thin-film transistor.

[0014] In an exemplary embodiment of the present inventive concept, the signal includes an optical signal and/or a sound signal.

[0015] According to an exemplary embodiment of the present inventive concept, a method of manufacturing a display apparatus including: forming a display area and a sensor area on a substrate, wherein the display area includes a main pixel, and the sensor area includes an auxiliary pixel and a transmission portion; arranging on a side of the substrate a sensor configured to transmit a signal through the substrate via the transmission portion; and forming a blocking layer between the sensor and the auxiliary pixel, wherein the auxiliary pixel includes an auxiliary thin-film transistor including a semiconductor layer, and the blocking layer covers the semiconductor layer of the auxiliary thin-film transistor.

[0016] In an exemplary embodiment of the present inventive concept, the blocking layer is formed to have a same pattern as a pattern of the semiconductor layer of the auxiliary thin-film transistor.

[0017] In an exemplary embodiment of the present inventive concept, a width of the pattern of the blocking layer is greater than a width of the pattern of the semiconductor layer of the auxiliary thin-film transistor.

[0018] In an exemplary embodiment of the present inventive concept, the blocking layer has a different pattern from a pattern of the semiconductor layer of the auxiliary thin-film transistor.

[0019] In an exemplary embodiment of the present inventive concept, a thickness of the blocking layer is about 800 Å or greater.

[0020] In an exemplary embodiment of the present inventive concept, buffer layers are arranged between the auxiliary thin-film transistor and the blocking layer and between the blocking layer and the substrate, respectively.

[0021] In an exemplary embodiment of the present inventive concept, the auxiliary pixel further includes an organic light-emitting diode connected to the auxiliary thin-film transistor.

[0022] In an exemplary embodiment of the present inventive concept, the main pixel further includes a main thin-film transistor including a semiconductor layer, and a blocking layer is disposed between the sensor and the main thin-film transistor, and covers the semiconductor layer of the main thin-film transistor.

[0023] In an exemplary embodiment of the present inventive concept, the main pixel further includes an organic light-emitting diode connected to the main thin-film transistor.

[0024] In an exemplary embodiment of the present inventive concept, the signal includes an optical signal and/or a sound signal.

Description

BRIEF DESCRIPTION OF THE DRAWINGS

[0025] A more complete appreciation of the present disclosure and many of the attendant aspects thereof will be readily obtained as the same becomes better understood by reference to the following detailed description when considered in connection with the accompanying drawing, wherein:

[0026] FIG. 1 is a schematic perspective view of a display apparatus according to an exemplary embodiment of the present inventive concept;

[0027] FIG. 2 is a cross-sectional view of the display apparatus taken along a line A-A' of FIG. 1, according to an exemplary embodiment of the present inventive concept;

[0028] FIG. 3 is a plan view of the display apparatus of FIG. 1, according to an exemplary embodiment of the present inventive concept;

[0029] FIG. 4 is a schematic plan view in which an auxiliary pixel and a main pixel are arranged in a periphery of a sensor area of a display panel of FIG. 1, according to an exemplary embodiment of the present inventive concept;

[0030] FIG. 5 is an enlarged plan view of the auxiliary pixel of FIG. 4, according to an exemplary embodiment of the present inventive concept;

[0031] FIG. 6 is a plan view of a semiconductor layer and a blocking layer from FIG. 5, according to an exemplary embodiment of the present inventive concept;

[0032] FIG. 7A is a cross-sectional view of the semiconductor layer and the blocking layer taken along a line B-B' of FIG. 6, according to an exemplary embodiment of the present inventive concept;

[0033] FIG. 7B is a cross-sectional view illustrating a situation of a wire disconnection when a blocking layer is arranged below some regions of a semiconductor layer in a comparative example;

[0034] FIG. 8 is a cross-sectional view of the auxiliary pixel and the main pixel of FIG. 4, according to an exemplary embodiment of the present inventive concept;

[0035] FIGS. 9A, 9B, 9C and 9D are plan views each illustrating a structure of the blocking layer of FIG. 6, according to an exemplary embodiment of the present inventive concept; and

[0036] FIG. 10 is a schematic cross-sectional view of a display panel according to an exemplary embodiment of the present inventive concept.

DETAILED DESCRIPTION

[0037] Exemplary embodiments of the present inventive concept will now be described more fully with reference to the accompanying drawings. It is to be understood that the present inventive concept may be embodied in different forms and thus should not be construed as being limited to the exemplary embodiments set forth herein. It is to be understood that like reference numerals may refer to like elements throughout the specification.

[0038] Sizes of elements in the drawings may be exaggerated for clarity.

[0039] Hereinafter, embodiments will be described in detail with reference to the attached drawings.

[0040] FIG. 1 is a schematic perspective view of a display apparatus 1 according to an exemplary embodiment of the present inventive concept.

[0041] Referring to FIG. 1, the display apparatus 1 includes a display area DA configured to display an image and a non-display area NDA configured not to display an image. The display apparatus 1 may provide an image by using light emitted from a plurality of main pixels P_m arranged in the display area DA.

[0042] The display apparatus 1 includes a sensor area SA. For example, the sensor area SA may be provided below an area in which a component 20 such as a sensor using an optical signal or a sound signal is arranged. This will be described later with reference to FIG. 2. The sensor area SA may include a transmission portion TA through which an optical signal and/or a sound signal is transmitted. The optical signal and/or sound signal may each be output from the component 20 to

outside (e.g., an external device) or may be output from the outside toward the component **20**. According to an exemplary embodiment of the present inventive concept, when infrared light passes through the sensor area SA, light transmittance may be about 10% or greater. According to an exemplary embodiment of the present inventive concept, the light transmittance may be about 20% or greater, about 25% or greater, about 50% or greater, about 85% or greater, or about 90% or greater.

[0043] According to the present embodiment, in the sensor area SA, a plurality of auxiliary pixels Pa may be arranged and an image may be provided by using light emitted from the auxiliary pixels Pa. The image provided in the sensor area SA is an auxiliary image, and may have a lower resolution than an image provided in the display area DA by the main pixels Pm. For example, since the sensor area SA includes the transmission portion TA through which an optical signal and/or a sound signal may pass, the number of auxiliary pixels Pa that may be arranged in a unit area may be less than the number of main pixels Pm arranged in the unit area of the display area DA.

[0044] The sensor area SA may be at least partially surrounded by the display area DA. For example, FIG. 1 shows that the whole sensor area SA is surrounded by the display area DA.

[0045] Hereinafter, according to an exemplary embodiment of the present exemplary embodiment of the present inventive concept, an organic light-emitting display apparatus is described as an example of the display apparatus **1**. However, the present inventive concept is not limited thereto. According to an exemplary embodiment of the present inventive concept, various types of display apparatuses such as an inorganic electroluminescence (EL) display apparatus, a quantum dot light-emitting display, etc. may be used.

[0046] FIG. 1 shows that the sensor area SA is arranged on a part (e.g., an upper right part) of the display area DA having a rectangular shape. However, the present inventive concept is not limited thereto. The display area DA may have a shape such as a circle, an oval, or a polygon, for example, a triangle or a pentagon, or the like. The number of sensor areas SA and/or a location of the sensor area SA may be variously changed.

[0047] FIG. 2 is a schematic cross-sectional view of the display apparatus **1** according to an exemplary embodiment of the present inventive concept. The schematic cross-sectional view of the display apparatus **1** shown in FIG. 2 may correspond to a line A-A' of FIG. 1.

[0048] Referring to FIG. 2, the display apparatus **1** may include a display panel **10** including a display element. The display apparatus **1** may further include the component **20** corresponding to the sensor area SA.

[0049] The display panel **10** may include a substrate **100**, a display element layer **200** disposed on the substrate **100**, and a thin-film encapsulation layer **300** as a sealing member configured to seal the display element layer **200**. In addition, the display panel **10** may further include a lower protective film **175** disposed below the substrate **100**.

[0050] The substrate **100** may include, for example, glass or a polymer resin. For example, the polymer resin may include polyethersulphone (PES), polyacrylate, polyetherimide (PEI), polyethylene naphthalate (PEN), polyethylene terephthalate (PET), polyphenylene sulfide (PPS), polyarylate (PAR), polyimide (PI), polycarbonate (PC), cellulose acetate propionate (CAP), and/or the like. The substrate **100** including a polymer resin may be flexible, rollable, and/or bendable. The substrate **100** may have a multi-layered structure including a layer including the above-described polymer resin, and an inorganic layer.

[0051] The display element layer **200** may include a circuit layer including a main thin-film transistor TFT and an auxiliary thin-film transistor TFT', an organic light-emitting diode OLED as the display element, and insulating layers IL and IL' disposed in a periphery of the circuit layer and the organic light-emitting diode OLED.

[0052] In the display area DA, the main pixels Pm are arranged therein and may include the main thin-film transistor TFT and the organic light-emitting diode OLED (e.g., a first OLED) connected

to the main thin-film transistor TFT. In the sensor area SA, the auxiliary pixels Pa and wires WL may be arranged therein and may include the auxiliary thin-film transistor TFT' and the organic light-emitting diode OLED (e.g., a second OLED) connected to the auxiliary thin-film transistor TFT'.

[0053] In addition, in the sensor area SA, the transmission portion TA may be arranged therein and might not include the auxiliary thin-film transistor TFT' and the display element. The transmission portion TA may be understood as an area transmitting an optical signal and/or a sound signal, each emitted from the component **20**, or an optical signal incident and/or a sound signal, each received by the component **20** from the external device.

[0054] The component **20** may be arranged in the sensor area SA. The component **20** may be an electronic element using light or sound. For example, the component **20** may be a sensor configured to receive and use light, such as an infrared sensor, a sensor configured to measure a distance or recognize a fingerprint by outputting and detecting light or sound, a small lamp configured to output light, a speaker configured to output sound, etc. For example, the component **20** may be a combination of the sensor configured to measure a distance or recognize a fingerprint by outputting and detecting light or sound, the small lamp configured to output light, and the speaker configured to output sound. When the component **20** is an electronic element using light, the component **20** may use light of various wavelengths, such as visible light, infrared light, and/or ultraviolet light. A plurality of components **20** may be arranged in the sensor area SA. For example, a light-emitting device and a light-receiving device may be included as components **20** in a sensor area SA. In addition, a light-emitting unit and a light-receiving unit may be included in one component **20**.

[0055] In the current embodiment, a blocking layer BSM may be arranged in the sensor area SA. The blocking layer BSM may be arranged below the wires WL and the auxiliary thin-film transistor TFT' to correspond to the wires WL and the auxiliary thin-film transistor TFT'. For example, the blocking layer BSM may overlap the wires WL and the auxiliary thin-film transistor TFT. The blocking layer BSM may block external light from reaching the auxiliary pixels Pa including the wires WL and the auxiliary thin-film transistor TFT'. For example, the blocking layer BSM may block light emitted from the component **20** from reaching the wires WL and the auxiliary pixels Pa.

[0056] An electrostatic voltage or a signal is applied to the blocking layer BSM to thereby prevent a pixel circuit from being damaged by an electrostatic discharge. In addition, the blocking layer BSM has an arrangement that may correspond with the auxiliary pixels Pa in a plan view. This will be described later in detail.

[0057] The thin-film encapsulation layer **300** may include at least one inorganic encapsulation layer and at least one organic encapsulation layer. In relation to this, FIG. 2 shows first and second inorganic encapsulation layers **310** and **330** and an organic encapsulation layer **320** disposed therebetween.

[0058] The first and second inorganic encapsulation layers **310** and **330** may include at least one inorganic insulating material, such as aluminum oxide, titanium oxide, tantalum oxide, hafnium oxide, zinc oxide, silicon oxide, silicon nitride, and/or silicon oxynitride.

[0059] For example, the organic encapsulation layer **320** may include PET, PEN, PC, PI, polyethylene sulfonate, polyoxymethylene, polyarylate, hexamethyldisiloxane, acrylic-based resin (e.g., polymethyl methacrylate, polyacrylic acid, etc.) or a combination thereof.

[0060] The lower protective film **175** is attached to a lower surface of the substrate **100** to support and protect the substrate **100**. The lower protective film **175** may include an opening **175OP** corresponding to the sensor area SA. Light transmittance of the sensor area SA may be increased by arranging the opening **175OP** in the lower protective film **175**. The lower protective film **175** may include, for example, PET or PI.

[0061] A size of the sensor area SA may be greater than that of an area in which the component **20** is arranged. For example, a size of the opening **175OP** in the lower protective film **175** might not

match a size of the sensor area SA. For example, a size of the opening **175OP** may be less than that of the sensor area SA.

[0062] Although not illustrated, on the display panel **10**, an input detection member configured to detect a touch input, a reflection prevention member including a polarizer, a retarder, a color filter, and/or a black matrix, and an element such as a transparent window may be further arranged.

[0063] In the current embodiment, it is shown that a thin-film encapsulation layer **300** is used as an encapsulation member configured to seal the display element layer **200**. However, the present inventive concept is not limited thereto. For example, as a member configured to seal the display element layer **200**, an encapsulation substrate adhered to the substrate **100** by using a sealant or a frit may be used.

[0064] FIG. **3** is a plan view of a wiring structure of the display apparatus **1** of FIG. **1**, according to an exemplary embodiment of the present inventive concept.

[0065] Referring to FIG. **3**, the display panel **10** includes the plurality of main pixels P_m in the display area DA. The main pixels P_m may each include a display element such as an organic light-emitting diode. Each of the main pixels P_m may emit, for example, red, green, blue, or white light via the organic light-emitting diode. The main pixels P_m herein may be understood as a pixel emitting light of a color of red, green, blue, or white, as described above. The display area DA is covered by the encapsulation member described with reference to FIG. **2** to be protected from external air and/or moisture.

[0066] The sensor area SA may be arranged in the display area DA. In the sensor area SA, the plurality of auxiliary pixels P_a are arranged. The auxiliary pixels P_a may each include a display element such as an organic light-emitting diode. Each of the auxiliary pixels P_a may emit, for example, red, green, blue, or white light via the organic light-emitting diode. The auxiliary pixels P_a herein may be understood as a pixel emitting light of a color of red, green, blue, or white, as described above. The sensor area SA may include the transmission portion TA between the auxiliary pixels P_a.

[0067] In an exemplary embodiment of the present inventive concept, a main pixel P_m and an auxiliary pixel P_a may include a same pixel circuit. However, the present inventive concept is not limited thereto. A pixel circuit included in a main pixel P_m may be different from that included in the auxiliary pixel P_a.

[0068] Since the sensor area SA includes the transmission portion TA, resolution of the sensor area SA may be less than that of the display area DA. For example, resolution of the sensor area SA may be about ½ of the resolution of the display area DA. In an exemplary embodiment of the present inventive concept, resolution of the display area DA may be about 400 ppi or greater, and resolution of the sensor area SA may be about 200 ppi.

[0069] Each of the main pixels P_m and the auxiliary pixels P_a may be electrically connected to outer circuits in the non-display area NDA. In the non-display area NDA, a first scan driving circuit **110**, a second scan driving circuit **120**, a terminal **140**, a data driving circuit **150**, a first power supply line **160**, and a second power supply line **170** may be arranged.

[0070] The first scan driving circuit **110** may provide a scan signal to each of the main pixels P_m and the auxiliary pixels P_a via a scan line SL. The first scan driving circuit **110** may provide a light emission control signal to each of the main pixels P_m and the auxiliary pixels P_a via a light emission control line EL. The second scan driving circuit **120** may be arranged in parallel with the first scan driving circuit **110** to have the display area DA disposed therebetween. Some of the main pixels P_m and the auxiliary pixels P_a in the display area DA may be electrically connected to the first scan driving circuit **110**. Remaining main pixels P_m and the auxiliary pixels P_a may be connected to the second scan driving circuit **120**. According to an exemplary embodiment of the present inventive concept, the second scan driving circuit **120** might not be included.

[0071] The terminal **140** may be arranged on a side of the substrate **100**. The terminal **140** might not be covered by an insulating layer but may be exposed to be electrically connected to a printed

circuit board PCB. A terminal PCB-P of the printed circuit board may be electrically connected to the terminal **140** of the display panel **10**. The printed circuit board PCB transmits a signal or power generated from a controller to the display panel **10**. A control signal generated by the controller may be transmitted to the first and second scan driving circuits **110** and **120** via the printed circuit board PCB. The controller may provide first and second power voltages ELVDD and ELVSS (shown in FIGS. **4A** and **4B** to be described later) to the first and second power supply lines **160** and **170**, respectively, via first and second connection lines **161** and **171**. The first power voltage ELVDD may be provided to each of the main pixels Pm and the auxiliary pixels Pa via a driving voltage line PL connected to the first power supply line **160**. The second power voltage ELVSS may be provided to an opposite electrode of each of the main pixels Pm and the auxiliary pixels Pa, each connected to the second power supply line **170**.

[0072] The data driving circuit **150** is electrically connected to the data line DL. A data signal of the data driving circuit **150** may be provided to each of the main pixels Pm and the auxiliary pixels Pa via a connection line **151** connected to the terminal **140** and the data line DL connected to the connection line **151**. FIG. **3** shows that the data driving circuit **150** is arranged on the printed circuit board PCB. According to an exemplary embodiment of the present inventive concept, the data driving circuit **150** may be arranged on the substrate **100**. For example, the data driving circuit **150** may be arranged between the terminal **140** and the first power supply line **160**.

[0073] The first power supply line **160** may include a first subline **162** and a second subline **163**. The first subline **162** and the second subline **163** extend in parallel to each other in an x-direction to have the display area DA provided therebetween. The second power supply line **170** may partially surround the display area DA in a loop form of which a side is open. For example, the second power supply line **170** may have a square or rectangular shape with an open side or a “U-shape”.

[0074] FIG. **4** is a schematic plan view illustrating an auxiliary pixel Pa in the sensor area SA and a main pixel Pm adjacent to the sensor area SA. For example, the auxiliary pixel PA is disposed between the main pixel Pm and the transmission portion TA. A semiconductor layer **1130** is arranged on each of the auxiliary pixel Pa and the main pixel Pm. The semiconductor layer **1130** is an active layer of the auxiliary thin-film transistor TFT' and the main thin-film transistor TFT included in the auxiliary pixel Pa and the main pixel Pm, respectively. The semiconductor layer **1130** in the auxiliary pixel Pa includes a same pattern as that in the main pixel Pa. Here, the semiconductor layer **1130** of each of the auxiliary pixel Pa and the main pixel Pm is schematically shown to briefly describe that the blocking layer BSM is arranged to block an optical signal or a sound signal of the component **20** from reaching the semiconductor layer **1130**. For example, the semiconductor layer **1130** is properly blocked by the blocking layer BSM to prevent a signal from being distributed in the semiconductor layer **1130** and thus prevent current leakage, etc. Such characteristics will be described later with reference to FIG. **6**.

[0075] FIG. **5** is an enlarged plan view in which various wires on the auxiliary pixels Pa overlap each other. The auxiliary pixels Pa have the semiconductor layer **1130** as an element and include **7** thin-film transistors such as a driving thin-film transistor T1, a switching thin-film transistor T2, a compensating thin-film transistor T3, a first initialization driving thin-film transistor T4, an operation-control thin-film transistor T5, a light emission control thin-film transistor T6, and a second initialization driving thin-film transistor T7. It may be understood that the main pixels Pm also have a structure in which such various wires are arranged.

[0076] As shown in FIG. **5**, the auxiliary thin-film transistor TFT' has a structure in which the driving thin-film transistor T1, the switching thin-film transistor T2, the compensating thin-film transistor T3, the first initialization driving thin-film transistor T4, the operation-control thin-film transistor T5, the light-control thin-film transistor T6, and the second initialization driving thin-film transistor T7 are arranged along the semiconductor layer **1130**. The semiconductor layer **1130** is arranged on the substrate **100** on which a first buffer layer **111a** (shown in, e.g., FIG. **8**) including an inorganic insulating material is arranged.

[0077] Some regions of the semiconductor layer 1130 correspond to active layers of the driving thin-film transistor T1, the switching thin-film transistor T2, the compensating thin-film transistor T3, the first initialization driving thin-film transistor T4, the operation-control thin-film transistor T5, the light-control thin-film transistor T6, and the second initialization driving thin-film transistor T7. For example, the active layers of the driving thin-film transistor T1, the switching thin-film transistor T2, the compensating thin-film transistor T3, the first initialization driving thin-film transistor T4, the operation-control thin-film transistor T5, the light-control thin-film transistor T6, and the second initialization driving thin-film transistor T7 are connected to each other and are curved to have various forms. Hereinafter, an active layer may be referred to as a semiconductor layer.

[0078] A brief description of the auxiliary thin-film transistors TFT' including the 7 thin-film transistors is as follows.

[0079] The driving thin-film transistor T1 includes a driving gate electrode G1 overlapping a driving channel area, and a driving source electrodes S1 and a driving drain electrode at both ends of the driving channel area, respectively. The driving channel area overlapping the driving gate electrode G1 has a bent shape, such as an omega shape, to thereby provide a long channel area in a relatively narrow space. When the driving channel area is long, a gray scale of light emitted from the organic light-emitting diode OLED may be accurately controlled and display quality may be increased since a driving range of a gate voltage is widened.

[0080] The switching thin-film transistor T2 includes a switching gate electrode G2 overlapping a switching channel area, and a switching source electrode S2 and a switching drain electrode D2 at both ends of the switching channel area, respectively. The switching drain electrode D2 may be connected to the driving source electrode S1.

[0081] The compensation thin-film transistor T3 is a dual thin-film transistor. The compensation thin-film transistor T3 may include compensation gate electrodes G3 overlapping two compensation channel areas, and a compensation source electrode S3 and a compensation drain electrode D3 arranged at both outer ends of the two compensation channel areas, respectively. For example, the compensation thin-film transistor T3 may include two compensation gate electrodes G3 respectively overlapping the two compensation channel areas. The compensation thin-film transistor T3 may be connected to the driving gate electrode G1 of the driving thin-film transistor T1 via a node connection line 1174 that is to be described later.

[0082] The first initialization driving thin-film transistor T4 is a dual thin-film transistor. The first initialization driving thin-film transistor T4 may include first initialization gate electrodes G4 overlapping two first initialization channel areas, and a first initialization source electrode S4 and a first initialization drain electrode D4 arranged at both outer ends of the two first initialization channel areas, respectively.

[0083] The operation-control thin-film transistor T5 may include an operation-control gate electrode G5 overlapping an operation-control channel area, and an operation-control source electrode S4 and an operation-control drain electrode D5 arranged at both ends of the operation-control channel area, respectively. The operation-control drain electrode D5 may be connected to the driving source electrode S1.

[0084] The light emission control thin-film transistor T6 may include a light emission control gate electrode G6 overlapping a light emission control channel area, and a light emission control source electrode S6 and a light emission control drain electrode D6 arranged at both ends of the light emission control channel area, respectively. The light emission control source electrode S6 may be connected to the driving drain electrode D1.

[0085] The second initialization driving thin-film transistor T7 may include a second initialization gate electrode G7 overlapping a second initialization channel area, and a second initialization source electrode S7 and a second initialization drain electrode D7 arranged at both ends of the second initialization channel area, respectively.

[0086] The auxiliary thin-film transistor TFT' may be connected to signal lines (e.g., a scan line SL, a previous scan line SL-1, a light emission control line EL, and a driving gate electrode DL), an initialization voltage line VL, and the driving voltage line PL.

[0087] On the semiconductor layer **1130**, the scan line SL, the previous scan line SL-1, the light emission control line EL, and the driving gate electrode G1 may be arranged to have an insulating layer (insulating layers) therebetween.

[0088] The scan line SL may extend in a first direction. Regions of the scan line SL may correspond to the switching gate channel G2 and the compensation gate electrode G3. For example, regions of the scan line SL overlapping with the switching channel area of the switching thin-film transistor T2 and the two compensation channel areas of the compensating thin-film transistor T3 may be the switching gate channel G2 and the compensation gate electrode G3.

[0089] The previous scan line SL-1 extends in the first direction. Some regions of the previous scan line SL-1 may correspond to the first and second initialization gate electrodes G4 and G7. For example, regions of the previous scan line SL-1 overlapping with the two first initialization channel areas of the first initialization driving thin-film transistors T4 and the second initialization channel area of the second initialization driving thin-film transistor T7 may be the first and second initialization gate electrodes G4 and G7, respectively.

[0090] The light emission control line EL extends in the first direction. Regions of the light emission control line EL may correspond to the operation-control gate electrode G5 and light emission control gate electrode G6. For example, regions of the light emission control line EL overlapping with the operation-control channel area of the operation-control thin-film transistor T5 and the light emission control channel area of the light emission control thin-film transistor T6 may be the operation-control and light emission control gate electrodes G5 and G6, respectively.

[0091] The driving gate electrode G1 is a floating electrode, and may be connected to the compensation thin-film transistor T3 via a node connection line **1174** described above.

[0092] An electrode voltage line HL may be arranged on the scan line SL, the previous scan line SL-1, the light emission control line EL, and the driving gate electrode G1 to have an insulating layer (insulating layers) therebetween.

[0093] The electrode voltage line HL may extend in the first direction to cross the data line DL and the driving voltage line PL. A part of the electrode voltage line HL may cover at least a part of the driving gate electrode G1, and together with the driving gate electrode G1, constitute a storage capacitor Cst. For example, the driving gate electrode G1 may be a first storage capacitive plate CE1 of the storage capacitor Cst, and a part of the electrode voltage line HL may be a second storage capacitive plate CE2 of the storage capacitor Cst.

[0094] The second storage capacitive plate CE2 of the storage capacitor Cst is electrically connected to the driving voltage line PL. In relation to this, the electrode voltage line HL may be connected to the driving voltage line PL on the electrode voltage line HL via a contact hole CNT. Accordingly, the electrode voltage line HL may have a same voltage level (e.g., a constant voltage) as that of the driving voltage line PL. For example, the electrode voltage line HL may have a constant voltage of about +5 V. The electrode voltage line HL may be understood as a driving voltage line in a transverse direction.

[0095] The driving voltage line PL extends in a second direction, and the electrode voltage line HL is electrically connected to the driving voltage line PL and extends in the first direction crossing the second direction. Thus, a plurality of driving voltage lines PL and a plurality of electrode voltage lines HL may constitute a mesh structure in a display area.

[0096] On the electrode voltage lines HL, the data line DL, the driving voltage line PL, an initialization connection line **1173**, and a node connection line **1174** may be arranged to have an insulating layer (e.g., insulating layers) therebetween. For example, insulating layers may be disposed between each of the layers of the data line DL, the driving voltage line PL, an initialization connection line **1173**, and a node connection line **1174**.

[0097] The data line DL may extend in the second direction and may be connected to the switching source electrode S2 of the switching thin-film transistor T2 via the contact hole **1154**. A part of the data line DL may be understood as a switching source electrode S2.

[0098] The data line DL may extend in the second direction and, as described above, may be connected to the electrode voltage line HL via the contact hole CNT. In addition, the driving voltage line PL may be connected to the operation-control thin-film transistor T5 via a contact hole **1155**. The driving voltage line PL may be connected to the operation-control source electrode S5 via the contact hole **1155**.

[0099] An end of the initialization connection line **1173** is connected to the first and second initialization driving thin-film transistors T4 and T7 via a contact hole **1152**, and the other end of the initialization connection line **1173** may be connected to the initialization voltage line VL via the contact hole **1151**.

[0100] An end of the node connection line **1174** is connected to the compensation drain electrode D3 via a contact hole **1156**. The other end of the node connection line **1174** may be connected to the driving gate electrode G1 via the contact hole **1157**.

[0101] The initialization voltage line VL may be arranged on the data line DL, the driving voltage line PL, the initialization connection line **1173**, and the node connection line **1174**, to have an insulating layer (or, e.g., insulating layers) between the initialization voltage line VL and the data line DL, the driving voltage line PL, the initialization connection line **1173**, and the node connection line **1174**.

[0102] The initialization voltage line VL extends in the first direction. The initialization voltage line VL may be connected to the first and second initialization driving thin-film transistors T4 and T7 via the initialization connection line **1173**. The initialization voltage line VL may have a constant voltage (e.g., about -2 V, etc.)

[0103] The initialization voltage line VL is arranged on a same layer as the pixel electrode **210** of the organic light-emitting diode OLED (shown in, e.g., FIG. 8) and include a same material as that of the pixel electrode **210**. The pixel electrode **210** may be connected to the light emission control thin-film transistor T6. The pixel electrode **210** is connected to connection metal **1175** via a contact hole **1163**. The connection metal **1175** may be connected to the light emission control drain electrode D6 via a contact hole **1153**.

[0104] As described above, the semiconductor layer **1130** of the auxiliary thin-film transistors TFT' is arranged on the substrate **100** to constitute main layers of a plurality of thin-film transistors including the driving thin-film transistor T1, the switching thin-film transistor T2, the compensating thin-film transistor T3, the first initialization driving thin-film transistor T4, the operation-control thin-film transistor T5, the light-control thin-film transistor T6, and the second initialization driving thin-film transistor T7. When an optical signal or a sound signal of the component **20** is directly transmitted to the semiconductor layer **1130**, leaked current may occur in each of the auxiliary thin-film transistors TFT' such as the driving thin-film transistor T1, the switching thin-film transistor T2, the compensating thin-film transistor T3, the first initialization driving thin-film transistor T4, the operation-control thin-film transistor T5, the light-control thin-film transistor T6, and the second initialization driving thin-film transistor T7 to thereby obstruct accurate operation.

[0105] Accordingly, to prevent leakage of current, the blocking layer BSM is arranged below the semiconductor layer **1130** as shown in FIG. 6. The blocking layer BSM is arranged between the component **20** disposed below the substrate **100** and the semiconductor layer **1130** disposed above the substrate **100** to thereby block an optical signal or a sound signal emitted directly to the semiconductor layer **1130** from the component **20**. Since the blocking layer BSM may include a molybdenum (Mo) material, a thickness t_1 (shown in FIG. 7) of the blocking layer BSM may be about 800 Å to perform a blocking function. However, when the blocking layer BSM having a thickness of about 800 Å or greater is arranged only in some regions below the semiconductor layer

1130, for example, only a position in which the auxiliary thin-film transistors TFT' is arranged, a risk of a wire disconnection in the semiconductor layer **1130** may increase due to a height difference. The auxiliary thin-film transistors TFT' includes the driving thin-film transistor T1, the switching thin-film transistor T2, the compensating thin-film transistor T3, the first initialization driving thin-film transistor T4, the operation-control thin-film transistor T5, the light-control thin-film transistor T6, and the second initialization driving thin-film transistor T7. Accordingly, in the present embodiment, to prevent a risk of wire disconnection, the blocking layer BSM may have a same pattern as that of the semiconductor layer **1130** to thereby cover a whole area of the semiconductor layer **1130**. To block the semiconductor layer **1130**, a width W2 of the blocking layer BSM is greater than a width W1 of the semiconductor layer **1130** ($W1 < W2$).

[0106] Here, a problem of a wire disconnection that may be caused by a height difference between, for example, the blocking layer BSM and the semiconductor layer **1130** may be understood by FIGS. 7A and 7B. FIG. 7A illustrates a structure of the semiconductor layer **1130** and the blocking layer BSM taken along a line B-B' of FIG. 6 according to an exemplary embodiment of the present inventive concept. FIG. 7B illustrates an example in which the blocking layer BSM is arranged only below some regions of the semiconductor layer **1130** according to a comparative example.

[0107] FIG. 7A shows a structure in which the blocking layer BSM is arranged below a whole area of the semiconductor layer **1130** in the present embodiment. Since the semiconductor layer **1130** is arranged only on the blocking layer BSM without having to be arranged on surface levels of different heights due to the thickness of the blocking layer BSM, a wire disconnection problem that may be caused by the height difference does not occur.

[0108] However, as shown in FIG. 7B, when the blocking layer BSM is only below some regions of the semiconductor layer **1130**, the semiconductor layer **1130** is, for example, arranged on a low surface level and a high surface level, each caused by a height difference due to the thickness of the blocking layer BSM. In this case, since the height difference increases, the thicker the blocking layer BSM is, the more likely a wire disconnection portion **1130a** is to be caused. Accordingly, in the present embodiment, as shown in FIG. 6, as the blocking layer BSM includes a same pattern as that of the semiconductor layer **1130** to thereby cover the whole area of the semiconductor layer **1130**, a risk of a wire disconnection that may be caused by a height difference may be resolved.

[0109] Hereinafter, referring to FIG. 8, structures of cross-sections of the auxiliary pixels Pa and the main pixels Pm having the above-described characteristics are described. It may be understood that FIG. 8 is a view of a stacked structure on the substrate **100** schematically shown in FIG. 2.

[0110] For example, the substrate **100** may include glass or a polymer resin. A polymer resin may include PES, polyacrylate, PEI, PEN, PET, PPS, PAR, PI, PC, CAP, etc. The substrate **100** including a polymer resin may be flexible, rollable, and/or bendable. The substrate **100** may have a multi-layered structure including a layer including the above-described polymer resin, and an inorganic layer.

[0111] A buffer layer **111** is arranged on the substrate **100**. The buffer layer **111** may reduce or block penetration of a foreign substance, moisture, or external air from below the substrate **100**, and provide a flat surface onto the substrate **100**. The buffer layer **111** may include an inorganic material such as oxide or nitride, an organic material, or a composite of an organic material and an inorganic material. The buffer layer **111** may include a single-layered or multi-layered structure including an inorganic material and an organic material. Between the substrate **100** and the buffer layer **111**, a barrier layer may be further included. The barrier layer may block penetration of external air. The buffer layer **111** may have a structure in which the first buffer layer **111a** and a second buffer layer **111b** are stacked.

[0112] A gate electrode G is arranged on the semiconductor layer **1130** with a first gate insulating layer **112** disposed therebetween. The gate electrode G may have a single-layered or multi-layered structure including, for example, Mo, aluminum (Al), copper (Cu), titanium (Ti), etc. As an example, the gate electrode G may have a single layer including Mo. The scan line SL, the previous

scan line SL-1, and the light emission control line EL may be arranged on a same layer as that of the gate electrode G. For example, the gate electrode G, the scan line SL, the previous scan line SL-1, and the light emission control line EL may be arranged on the first gate insulating layer **112**. [0113] The first gate insulating layer **112** may include, for example, silicon oxide (SiO.sub.2), silicon nitride (SiN.sub.x), silicon oxynitride (SiON), aluminum oxide (Al.sub.2O.sub.3), titanium oxide (TiO.sub.2), tantalum pentaoxide (Ta.sub.2O.sub.5), hafnium oxide (HfO.sub.2), zinc peroxide (ZnO.sub.2), or the like.

[0114] A second gate insulating layer **113** may be included to cover the gate electrode G. The second gate insulating layer **113** may include, for example, SiO.sub.2, SiN.sub.x, SiON, Al.sub.2O.sub.3, TiO.sub.2, Ta.sub.2O.sub.5, HfO.sub.2, ZnO.sub.2, etc.

[0115] A source electrode S, a drain electrode D, and the driving voltage line PL may be arranged on an interlayer insulating layer **115**. The source electrode S, the drain electrode D, and the driving voltage line PL may include a conductive material including, for example, Mo, Al, Cu, Ti, etc., and may include a single layer or multiple layers including the above-described material.

[0116] The drain electrode D is connected to the pixel electrode **210** of the organic light-emitting diode OLED.

[0117] A planarization layer **117** is arranged on the source electrode S, the drain electrode D, and the driving voltage line PL. The organic light-emitting diode OLED may be arranged on the planarization layer **117**.

[0118] The planarization layer **117** may have a flat upper surface so that the pixel electrode **210** is disposed on a flat surface. The planarization layer **117** may have a single layer or multiple layers including an organic material. The planarization layer **117** may include a polymer such as benzocyclobutene (BCB), PI, hexamethyldisiloxane (HMDSO), polymethyl methacrylate (PMMA), or polystyrene (PS), a polymer derivative containing a phenol group, an acrylic-based polymer, an imide-based polymer, an aryl ether-based polymer, an amide-based polymer, a fluorine-based polymer, a p-xylene-based polymer, a vinyl alcohol-based polymer, or a blend thereof. The planarization layer **117** may include an inorganic material. The planarization layer **117** may include, for example, SiO.sub.2, SiN.sub.x, SiON, Al.sub.2O.sub.3, TiO.sub.2, Ta.sub.2O.sub.5, HfO.sub.2, ZnO.sub.2, or the like. When the planarization layer **117** includes an inorganic material, chemical polishing planarization may be performed on the planarization layer **117** according to the situation (e.g., the material of the planarization layer **117**). The planarization layer **117** may include both an organic material and an inorganic material.

[0119] The pixel electrode **210** may include a (semi-) light-transmitting electrode or a reflective electrode. In an exemplary embodiment of the present inventive concept, the pixel electrode **210** may include a reflective layer including, for example, silver (Ag), magnesium (Mg), Al, platinum (Pt), palladium (Pd), gold (Au), nickel (Ni), neodymium (Nd), iridium (Ir), chrome (Cr), or a compound thereof, and a transparent or translucent electrode layer disposed on the reflective layer. The transparent or translucent electrode layer may include at least one of, for example, indium tin oxide (ITO), indium zinc oxide (IZO), zinc oxide (ZnO), indium oxide (In.sub.2O.sub.3), indium gallium oxide (IGO), and/or aluminum zinc oxide (AZO). In an exemplary embodiment of the present inventive concept, the pixel electrode **210** may include a structure in which ITO/Ag/ITO are stacked.

[0120] A pixel-defining layer **119** may be arranged on the planarization layer **117**. The pixel-defining layer **119** may be formed by performing spin coating on an organic insulating material such as PI, polyamide, acrylic resin, BCB, HMDSO, phenol resin, etc.

[0121] The intermediate layer **220** of the organic light-emitting diode OLED may include an organic emissive layer. The organic emissive layer may include an organic material including a fluorescent material or a phosphorescent material emitting red, green, blue, or white light. The organic emissive layer may include a low-molecular weight organic material or a polymer organic material. Below or above the organic emissive layer, a functional layer such as a hole transport

layer (HTL), a hole injection layer (HIL), an electron transport layer (ETL), an electron injection layer (EIL), etc. may be further arranged. The intermediate layer **220** may be arranged on each of a plurality of pixel electrodes **210**. However, the intermediate layer **220** is not limited thereto, and may include a layer integrally arranged over a plurality of pixel electrodes **210**. For example, the intermediate layer **220** may be a single layer disposed on the plurality of pixel electrodes **210**. As such, the intermediate layer **220** may be variously modified.

[0122] For example, the opposite electrode **230** may be a transparent electrode or a reflective electrode. In an exemplary embodiment of the present inventive concept, the opposite electrode **230** may be a transparent or a translucent electrode, and may include a metal thin film having a low work function and including, e.g., Li, Ca, lithium-fluoride-calcium (LiF/Ca), lithium-fluoride-aluminum (LiF/Al), Al, Ag, Mg, or a compound thereof. In addition, a transparent conductive oxide (TCO) layer including, for example, ITO, IZO, ZnO or In.sub.2O.sub.3 may be further arranged over the metal thin film. The opposite electrode **230** is arranged over the display area DA and the peripheral area PA, and may be arranged above the intermediate layer **220** and the pixel-defining layer **119**. The opposite electrode **230** may be arranged integrally (e.g., as a single body) over a plurality of organic light-emitting diodes OLED to correspond to the plurality of pixel electrodes **210**.

[0123] When the pixel electrode **210** includes a reflective electrode and the opposite electrode **230** includes a light-transmitting electrode, and as light emitted from the intermediate layer **220** is emitted toward the opposite electrode **230**, the display apparatus **1** may be a top-emission type display apparatus. When the pixel electrode **210** is a transparent or translucent electrode and the opposite electrode **230** is a reflective electrode, and as light emitted from the intermediate layer **220** is emitted toward the substrate **100**, the display apparatus may be a rear-type emission type display apparatus. However, the present inventive concept is not limited thereto. In the present embodiment, the display apparatus **1** may be a dual-emission type display apparatus in which light is emitted in both front and rear directions.

[0124] In the current embodiment, the blocking layer BSM is arranged between the substrate **100** and the semiconductor layer **1130**, and between the substrate **100** and a wiring unit DW on the auxiliary pixel Pa. For example, the blocking layer BSM is arranged between the component **20** and the semiconductor layer **1130** and between the component **20** and the wiring unit DW to prevent the auxiliary thin-transistor TFT' and the wiring unit DW from being disturbed by an optical signal or a sound signal of the component **20**. For example, with respect to the semiconductor layer **1130** of the auxiliary thin-film transistor TFT', the blocking layer BSM covers a whole area of the semiconductor layer **1130** to protect the semiconductor layer **1130** as shown in FIG. 6.

[0125] Accordingly, in such a structure, a risk of current leakage due to an optical signal or a sound signal from the component **20** may be prevented as the blocking layer BSM blocks the optical signal or the sound signal. For example, since the semiconductor layer **1130** of the auxiliary thin-film transistor TFT' is sensitive to generation of current leak, a thickness of the blocking layer BSM may be about 800 Å or greater to prevent current leakage. In this case, a risk in which a wire disconnection in the semiconductor layer **1130** may be caused by a height difference due to a thickness of the blocking layer BSM may be resolved by covering a whole area of the semiconductor layer **1130** with the blocking layer BSM, as described above. For example, the blocking layer BSM may have a same pattern as that of the semiconductor layer **1130**.

[0126] Accordingly, as the blocking layer BSM prevents current leakage from being caused by a signal of the component **20**, operation of the component **20** and implementation of an image in the sensor area SA may be facilitated, and a wire disconnection in the semiconductor layer **1130** that may be caused by a height difference may be prevented.

[0127] In the present embodiment, a case in which the blocking layer BSM has a same pattern as that of the semiconductor layer **1130** is described as an example. However, as shown in FIGS. 9A

to 9D, the blocking layer BSM may be configured to have an area including a pattern different from that of the semiconductor layer **1130**. For example, when the blocking layer BSM covers a whole area of the semiconductor layer **1130**, even when the blocking layer does not have a same pattern as that of the semiconductor layer **1130**, the blocking layer BSM may prevent occurrence of current leakage and obstruct a wire disconnection. For example, the blocking layer BSM may cover beyond the area of the semiconductor layer **1130**.

[0128] In addition, in the above-described embodiment, as described with reference to FIG. **8**, a case in which the blocking layer BSM is arranged below the auxiliary thin-film transistor TFT' in the sensor area SA is described as an example. However, as shown in FIG. **10**, the blocking layer BSM may be also arranged below the main thin-film transistor TFT of the main pixel Pm to have a same material and a same pattern as those of the blocking layer BSM of the auxiliary thin-film transistor TFT'. For example, since the main pixel Pm is not arranged in the sensor area SA including the component **20**, even when the blocking layer is not arranged in the main pixel Pm, might not be impacted by the component **20**. However, to thoroughly block a mixture of noise caused not just by the component **20** but by another external light, the blocking layer BSM may be also arranged below the main thin-film transistor TFT of the main pixels Pm to cover a whole area of the semiconductor layer **1130**.

[0129] According to an exemplary embodiment of the present inventive concept, a display apparatus may include a sensor area provided in a display area. A component such as a sensor may be arranged in the sensor area. For example, according to an exemplary embodiment, a display apparatus including a blocking layer may prevent a device from being damaged by a component. However, the present inventive concept is not limited thereto.

[0130] While the present inventive concept has been particularly shown and described with reference to exemplary embodiments thereof, it will be apparent to those of ordinary skill in the art that various changes in form and detail may be made thereto without departing from the spirit and scope of the present inventive concept.

Claims

1. An apparatus, comprising: a display panel comprising a substrate and a blocking layer; and a sensor below the display panel, wherein the display panel comprises: the substrate comprising a display area and a sensor area, wherein the display area comprises a first pixel, and the sensor area comprises a second pixel, a wiring unit, and a transmission portion; and the blocking layer is disposed on the substrate and comprises a first blocking layer and a second blocking layer, wherein the sensor is configured to transmit or to receive a signal through the substrate via the transmission portion, wherein the second pixel comprises an organic light-emitting diode and a first semiconductor layer, wherein the second pixel is electrically connected to the wiring unit, wherein the first blocking layer overlaps the wiring unit and does not overlap the transmission portion, and wherein the second blocking layer fully covers a whole area of the first semiconductor layer in a top view of the substrate.
2. The apparatus of claim 1, wherein the wiring unit and the first semiconductor layer are disposed above the blocking layer, and the sensor is disposed below the blocking layer, wherein the wiring unit includes a plurality of wiring lines spaced apart from each other, and wherein the first blocking layer covers at least a portion of the plurality of wiring lines and spaces spaced apart between the plurality of wiring lines in a cross sectional view.
3. The apparatus of claim 2, wherein the first blocking layer is arranged between the sensor disposed below the substrate and the wiring unit disposed above the substrate, in a direction perpendicular to the substrate.
4. The apparatus of claim 2, wherein a gate electrode is disposed on the first semiconductor layer, and at least one wiring line of the plurality of wiring lines is arranged on a same layer as the gate

electrode.

5. The apparatus of claim 4, wherein the at least one wiring line comprises one wiring line of a previous scan line, a scan line, an initialization voltage line or a light emission control line.
6. The apparatus of claim 2, wherein the plurality of wiring lines are spaced apart from each other in a direction horizontal to the substrate, and a width of the first blocking layer is greater than a total width of the plurality of wiring lines.
7. The apparatus of claim 2, wherein the plurality of wiring lines are spaced apart from each other in a vertical direction of the substrate, and the first blocking layer covers the plurality of wiring lines that are spaced apart from each other.
8. The apparatus of claim 1, wherein the wiring unit and the first semiconductor layer are arranged on different layers.
9. The apparatus of claim 8, wherein the wiring unit is disposed on the first semiconductor layer with an insulating layer therebetween.
10. The apparatus of claim 1, wherein the first pixel comprises a second semiconductor layer, and the first blocking layer and the second blocking layer does not cover a whole area of the second semiconductor layer in a top view of the substrate.
11. The apparatus of claim 1, wherein the first blocking layer and the second blocking layer are arranged on a same layer.
12. The apparatus of claim 1, wherein the second blocking layer is arranged between the sensor disposed below the substrate and the first semiconductor layer disposed above the substrate, in a direction perpendicular to the substrate.
13. The apparatus of claim 12, wherein the second blocking layer has a same pattern as a pattern of the first semiconductor layer and a width of the pattern of the second blocking layer is greater than a width of the pattern of the first semiconductor layer.
14. The apparatus of claim 12, wherein the second blocking layer has a different pattern from a pattern of the first semiconductor layer.
15. The apparatus of claim 1, wherein the first pixel comprises a second semiconductor layer, a third blocking layer is further arranged between the substrate and the second semiconductor layer, and the third blocking layer fully covers a whole area of the second semiconductor layer in a top view of the substrate.
16. The apparatus of claim 1, wherein the organic light-emitting diode comprises a pixel electrode, an intermediate layer and an opposite electrode, a pixel defining layer covers an edge region of the pixel electrode to expose an emission area of the second pixel and defines an opening corresponding the transmission portion.
17. A display panel comprising: a substrate comprising a display area and a sensor area, wherein the display area comprises a first pixel, and the sensor area comprises a second pixel, a wiring unit, and a transmission portion; and a blocking layer is disposed on the substrate and comprises a first blocking layer and a second blocking layer, wherein the second pixel comprises an organic light-emitting diode and a first semiconductor layer, wherein the second pixel is electrically connected to the wiring unit, wherein the first blocking layer overlaps the wiring unit and does not overlap the transmission portion, and wherein the second blocking layer fully covers a whole area of the first semiconductor layer in a top view of the substrate.
18. The display panel of claim 17, wherein the wiring unit and the first semiconductor layer are disposed above the blocking layer wherein the wiring unit includes a plurality of wiring lines spaced apart from each other, and wherein the first blocking layer covers at least a portion of the plurality of wiring lines and spaces spaced apart between the plurality of wiring lines in a cross sectional view.
19. The display panel of claim 18, wherein a gate electrode is disposed on the first semiconductor layer, at least one wiring line of the plurality of wiring lines is arranged on a same layer as the gate electrode, and the at least one wiring line comprises one wiring line of a previous scan line, a scan

line, an initialization voltage line or a light emission control line.

20. The display panel of claim 17, wherein the organic light-emitting diode comprises a pixel electrode, an intermediate layer and an opposite electrode, and a pixel defining layer covers an edge region of the pixel electrode to expose an emission area of the second pixel and defines an opening corresponding the transmission portion.
